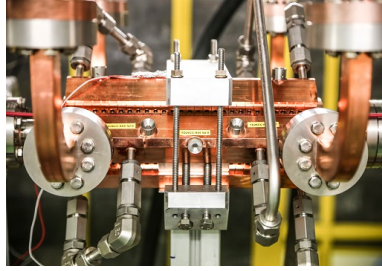


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**Test stands for breakdown studies on beam-driven
and RF-driven structures - Jay Hirshfield (Yale
University and Omega-P R&D, Inc).**

Session Classification: 1